

Search Notes

Application/Control No.

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Examiner

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Applicant(s)/Patent under
Reexamination

QIAN ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	253	3/1/2007	YG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
382	253	3/1/2007	YG

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US-PUPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) - See search history printout	3/1/2007	YG
IEEE Xplore - See search session history printout	3/1/2007	YG